

40V COMPLEMENTARY MEDIUM POWER TRANSISTOR IN SOT26

Features

- NPN + PNP Combination
- BV_{CEO} > 40 (-40)V
- BV_{ECO} > 6 (-3)V
- I_{CM} = 9 (-9)A Peak Pulse Current
- V_{CE(sat)} < 60 (-90)mV @ 1A
- $R_{CE(sat)} = 38 (58) m\Omega$
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 Standards for High Reliability

Description

Advanced process capability is used to achieve this high performance device. Combining NPN and PNP transistors in the SOT26 package provides a compact solution for the intended applications.

Mechanical Data

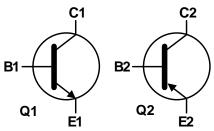
- Case: SOT26
- Case Material: Molded Plastic, "Green" Molding Compound
- UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Finish Matte Tin Plated Leads, Solderable per MIL-STD-202, Method 208[®]
- Weight: 0.015 grams (Approximate)

Applications

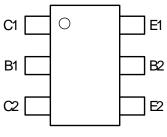
- MOSFET and IGBT Gate Driving
- Motor Drive







Device Symbol



Top View Pin-Out

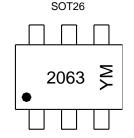
Ordering Information (Note 4)

Product	Marking	Reel size (inches)	Tape width (mm)	Quantity per reel
ZXTC2063E6TA	2063	7	8	3,000

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
- 2. See http://www.diodes.com/ for more information about Diodes Incorporated's definitions of Halogen and Antimony free, "Green" and Lead-Free.
- 3. Halogen and Antimony free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at http://www.diodes.com.

Marking Information



2063 = Product Type Marking Code YM = Date Code Marking Y or \overline{Y} = Year (ex: C = 2015) M or \overline{M} = Month (ex: 9 = September)

Date Code Key

Year	2015	2	016	2017	2018	2019	2020	202	1 20	22	2023	2024	2025
Code	С		D	E	F	G	Н	- 1	,	J	K	L	М
Month	h	Jan	Feb	Mar	Apr	May	Jun	Jul	Aug	Sep	Oct	Nov	Dec
Code)	1	2	3	4	5	6	7	8	9	0	N	D





May 2015

Absolute Maximum Ratings - Q1 (NPN Transistor) (@TA = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Unit
Collector-Base Voltage	V_{CBO}	130	V
Collector-Emitter Voltage	V_{CEO}	40	V
Emitter-Collector Voltage (Reverse blocking)	V _{ECO}	6	V
Emitter-Base Voltage	V _{EBO}	7	V
Continuous Collector Current	Ic	3.5	A
Peak Pulsed Collector Current	Ісм	9	Α
Base Current	lΒ	1	Α

Absolute Maximum Ratings - Q2 (PNP Transistor) (@TA = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Unit
Collector-Base Voltage	V _{CBO}	-45	V
Collector-Emitter Voltage	V_{CEO}	-40	V
Emitter-Collector Voltage (Reverse blocking)	V _{ECO}	-3	V
Emitter-Base Voltage	V_{EBO}	-7	V
Continuous Collector Current	Ic	-3	A
Peak Pulsed Collector Current	I _{CM}	-9	Α
Base Current	Ι _Β	-1	А

Thermal Characteristics (@TA = +25°C, unless otherwise specified.)

Characteristic		Symbol	Value	Unit	
	(Notes 5 & 9)		0.7 5.6		
	(Notes 6 & 9)		0.9 7.2		
Power Dissipation Linear Derating Factor	(Notes 6 & 10)	P_{D}	1.1 8.8	W mW/°C	
-	(Notes 7 & 9)		1.1 8.8		
	(Notes 8 & 9)		1.7 13.6		
Thermal Resistance, Junction to Ambient	(Notes 5 & 9) (Notes 6 & 9) (Notes 6 & 10)	$R_{ hetaJA}$	179 139 113	°C/W	
	(Notes 7 & 9) (Notes 8 & 9)		113 73	3,	
Thermal Resistance, Junction to Lead	(Note 11)	$R_{ hetaJL}$	87.58		
Operating and Storage Temperature Range		T _J , T _{STG}	-55 to +150	°C	

ESD Ratings (Note 12)

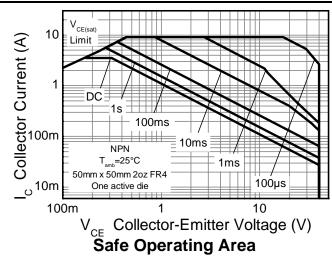
Characteristic	Symbol	Value	Unit	JEDEC Class
Electrostatic Discharge - Human Body Model	ESD HBM	4,000	V	3A
Electrostatic Discharge - Machine Model	ESD MM	400	V	С

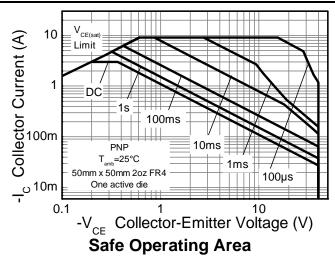
Notes: 5. For a device surface mounted on 15mm x 15mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions; the device is measured when operating in a steady-state condition.

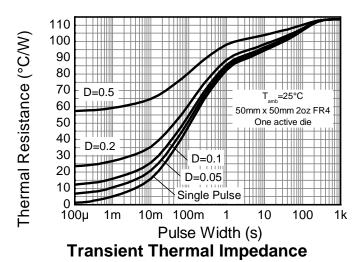
- 6. Same as Note (5), except the device is surface mounted on 25mm x 25mm 1oz copper.
- 7. Same as Note (5), except the device is surface mounted on 50mm x 50mm 2oz copper.
- 8. Same as Note (7), except the device is measured at t < 5 seconds.
- 9. For device with one active die, both collectors attached to a common heatsink.
- 10. For device with two active dice running at equal power, split heatsink 50% to each collector.
- 11. Thermal resistance from junction to solder-point (at the end of the collector lead).
- 12. Refer to JEDEC specification JESD22-A114 and JESD22-A115.

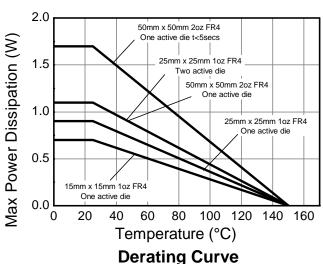


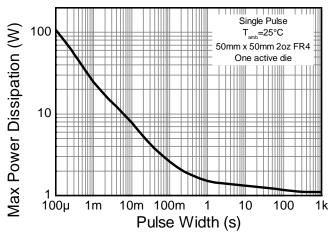
Thermal Characteristics and Derating Information















Electrical Characteristics – Q1 (NPN Transistor) (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS						
Collector-Base Breakdown Voltage	BV_{CBO}	130	170		V	$I_C = 100\mu A, I_E = 0$
Collector-Emitter Breakdown Voltage (Note 13)	BV_{CEO}	40	63		V	$I_C = 10 \text{mA}, I_B = 0$
Emitter-Base Breakdown Voltage	BV_{EBO}	7	8.3		V	$I_E = 100 \mu A, I_C = 0$
Emitter-Collector Breakdown Voltage (reverse blocking)	BV _{ECX}	6	7.4		V	I_E =100μA, R_{BC} < 1k Ω or 0.25V > V_{BC} > -0.25V
Emitter-Collector Breakdown Voltage (base open)	BV _{ECO}	6	7.4	_	V	$I_E = 100 \mu A$
Collector Cutoff Current	I _{CBO}	_	<1	50 20	nΑ μΑ	V _{CB} = 100V V _{CB} = 100V, T _A = +100°C
Collector Cutoff Current	I _{EBO}	_	<1	50	nA	V _{EB} = 5.6V
ON CHARACTERISTICS (Note 13)						
DC Current Gain	h _{FE}	300 280 40	450 400 60	900	_	$I_C = 10 \text{mA}, V_{CE} = 2 \text{V}$ $I_C = 1.0 \text{A}, V_{CE} = 2 \text{V}$ $I_C = 3.5 \text{A}, V_{CE} = 2 \text{V}$
Collector-Emitter Saturation Voltage	V _{CE(sat)}	_	50 85 150 135	60 110 220 195	mV	I _C = 1.0A, I _B = 100mA I _C = 1.0A, I _B = 20mA I _C = 2.0A, I _B = 40mA I _C = 3.5A, I _B = 350mA
Base-Emitter Saturation Voltage	V _{BE(sat)}	_	960	1,050	mV	$I_C = 3.5A$, $I_B = 350mA$
Base-Emitter Turn-On Voltage	V _{BE(on)}	_	860	950	mV	$I_C = 3.5A, V_{CE} = 2V$
SMALL SIGNAL CHARACTERISTICS						
Output Capacitance	C_{obo}		12	20	pF	$V_{CB} = 10V, f = 1.0MHz$
Current Gain-Bandwidth Product	f_T		190		MHz	$V_{CE} = 10V, I_{C} = 50mA, f = 100MHz$
Delay Time	t _d		64		ns	
Rise Time	t _r		108	_	ns	\/ = 10\/ - = 10 - = 10m4
Storage Time	ts		428	_	ns	$V_{CC} = 10V, I_C = 1A, I_{B1} = I_{B2} = 10mA$
Fall Time	t _f	_	130	_	ns	

Note: 13. Measured under pulsed conditions. Pulse width \leq 300 μ s. Duty cycle \leq 2%.





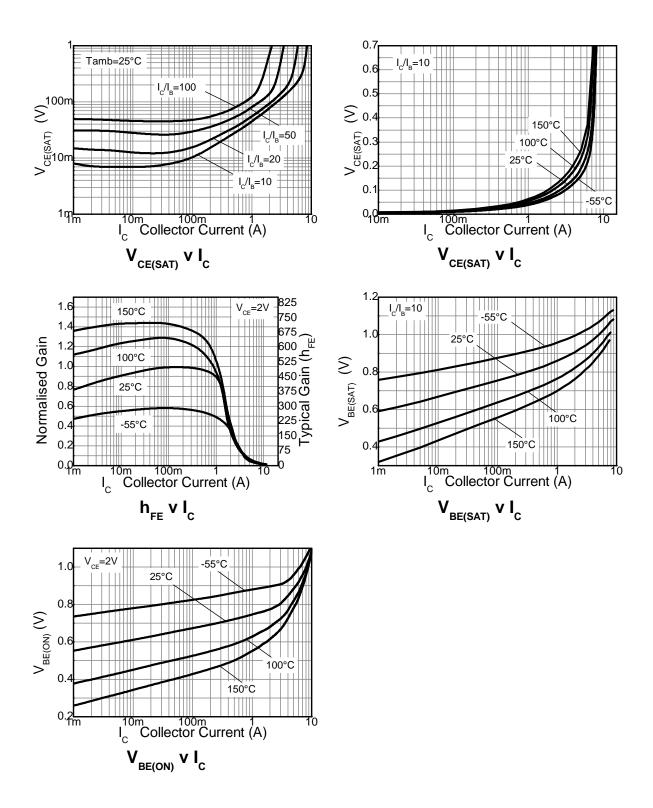
Electrical Characteristics – Q2 (PNP Transistor) (@TA = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS						
Collector-Base Breakdown Voltage	BV_CBO	-45	-80	_	V	$I_C = -100\mu A, I_E = 0$
Collector-Emitter Breakdown Voltage (Note 14)	BV _{CEO}	-40	-65	_	V	$I_C = -10 \text{mA}, I_B = 0$
Emitter-Base Breakdown Voltage	BV _{EBO}	-7	-8.3	_	V	$I_E = -100 \mu A, I_C = 0$
Emitter-Collector Breakdown Voltage (reverse blocking)	BV _{ECX}	-6	-7.4	_	V	$-I_E = 100\mu A$, $R_{BC} < 1k\Omega$ or 0.25V < $V_{BC} < -0.25V$
Emitter-Collector Breakdown Voltage (base open)	BV _{ECO}	-3	-8.7	_	V	$I_E = -100 \mu A$
Collector Cutoff Current	lasa	_	<1	-50	nA	V _{CB} = -36V
Collector Cutoff Current	I _{CBO}	_		-20	μΑ	$V_{CB} = -36V, T_A = +100^{\circ}C$
Collector Cutoff Current	I _{EBO}		<1	-50	nA	$V_{EB} = -5.6V$
ON CHARACTERISTICS (Note 14)						
		300	450	900		$I_C = -10 \text{mA}, V_{CE} = -2 \text{V}$
DC Current Gain	h _{FE}	200	280	_	_	$I_C = -1.0A$, $V_{CE} = -2V$
		20	50	_		$I_C = -3.0A$, $V_{CE} = -2V$
		_	-70	-90	mV	$I_C = -1.0A$, $I_B = -100mA$
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	_	-195	-290		$I_C = -1.0A$, $I_B = -20mA$
	` ,		-175	-260		$I_C = -3.0A$, $I_B = -300mA$
Base-Emitter Saturation Voltage	V _{BE(sat)}		-935	-1,000	mV	$I_C = -3.0A$, $I_B = -300mA$
Base-Emitter Turn-On Voltage	V _{BE(on)}		-855	-950	mV	I _C = -3.0A, V _{CE} = -2V
SMALL SIGNAL CHARACTERISTICS						
Output Capacitance	C_{obo}		17	25	pF	$V_{CB} = -10V, f = 1.0MHz$
Current Gain-Bandwidth Product	f⊤		270	_	MHz	V _{CE} = -10V, I _C = -50mA, f = 100MHz
Delay Time	t _d		57	_	ns	
Rise Time	t _r	_	69	_	ns	\
Storage Time	ts		154	_	ns	$V_{CC} = -10V$, $I_{C} = -1A$, $I_{B1} = I_{B2} = -10mA$
Fall Time	t _f	_	60	_	ns	

Note: 14. Measured under pulsed conditions. Pulse width \leq 300 μ s. Duty cycle \leq 2%.

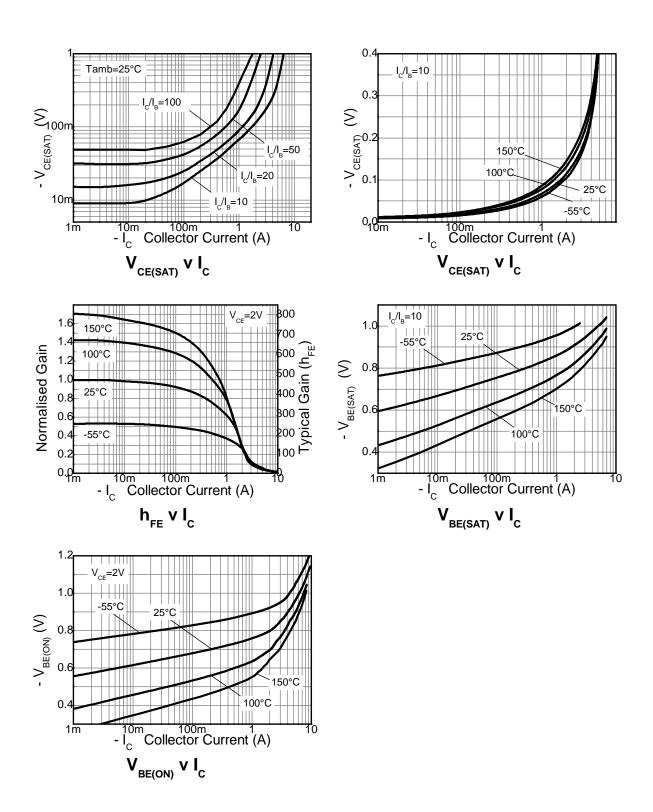


Typical Electrical Characteristics – Q1 (NPN Transistor) (@TA = +25°C, unless otherwise specified.)





Typical Electrical Characteristics – Q2 (PNP Transistor) (@T_A = +25°C, unless otherwise specified.)

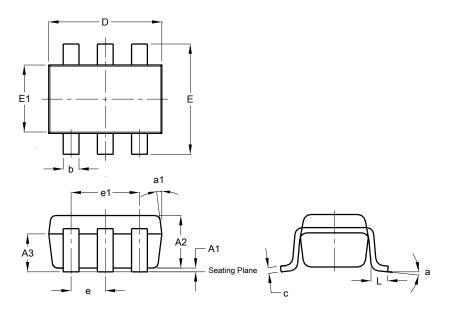




Package Outline Dimensions

Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for the latest version.

SOT26

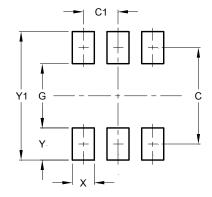


	SC	SOT26							
Dim	Min	Max	Тур						
A1	0.013	0.10	0.05						
A2	1.00	1.30	1.10						
А3	0.70	0.80	0.75						
b	0.35	0.50	0.38						
С	0.10	0.20	0.15						
D	2.90	3.10	3.00						
е	-	-	0.95						
e1	-	-	1.90						
Е	2.70	3.00	2.80						
E1	1.50	1.70	1.60						
L	0.35	0.55	0.40						
а	-	-	8°						
a1	-	-	7°						
All	Dimen	sions	in mm						

Suggested Pad Layout

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for the latest version.

SOT26



Dimensions	Value (in mm)
С	2.40
C1	0.95
G	1.60
X	0.55
Y	0.80
Y1	3.20





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